Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/085,607	HAYASHI ET AL.	
Examiner	Art Unit	
Monica Lewis	2822	

SEARCHED				
Class	Subclass	Date	Examiner	
257	79,80,84	4/29/2005	ML	
				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
-				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EIC Search	4/29/2005	ML
East Search	4/29/2005	ML
		: